Notice of References Cited Application/Control No. 10/658,464 Examiner Hau V. Phan Applicant(s)/Patent Under Reexamination KATOU ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,481,517	11-2002	Kobayashi et al.	180/65.3
	В	US-			
·	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	R					
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NON-PATENT DOCUMENTS

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